

NEW JERSEY LAB ID#:20012 : NEW YORK LAB ID#: 11376

GC/MS VOA CONFORMANCE/NON-CONFORMANCE SUMMARY

CHEMTECH PROJEC	CT NUMBER:	VX021025					
SequenceID :	VX021025			N	A	NO	YES
1. Chromatograms Labeled/Compounds Identified. (Field samples and Method Blanks)					✓		
2. GC/MS Tuning Spec (NOTE THAT THERE A	_	✓					
3. GC/MS Tuning Frequeseries	_	✓					
	calibration performe		erformed before sample sample analysis for 600 series	_	✓		
5. GC/MS Calibration R	equirements				✓		
	pounds and their rec		side the acceptable ranges. 25W.M) for Chloroethane is passing	on Quadratic Regression.	✓		
5b. Continous Calibratic If not met, list those con	· /		side the acceptable ranges.	-	✓		
6. Blank Contamination	- If yes, list compou	nds and concentrations	s in each blank:	_	✓		
7. Surrogate Recoveries If not met, list those con		coveries which fall outs	side the acceptable ranges.	-	✓		
8a. Matrix Spike/Matrix If not met, list those con			side the acceptable range.	_	✓		
8b. Blank Spike/Blank s If not met, list those con			side the acceptable range.	_	✓		
9. Internal Standard Area Comments:	a/Retention Time Sh	ift Meet Criteria			✓		

dimple

Analyst

02/11/2025



284 Sheffield Street, Mountainside, New Jersey 07092, Phone : 908 789 8900, Fax : 908 789 8922

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10. Analysis Holding Time Met			✓		
If not met, list number	of days exceeded for ea	ch sample:			

ADDITIONAL COMMENTS:

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SequenceID :

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NA NO YES

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Date